

# STP60NF03L

## **General features**

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub>	ID
STP60NF03L	30V	<0.01Ω	60A

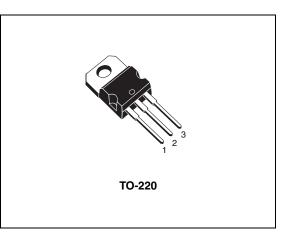
Low threshold drive

## Description

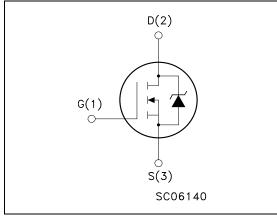
This Power MOSFET is the latest development of STMicroelectronis unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

# Applications

Switching application



# Internal schematic diagram



### **Order codes**

ſ	Part number	Marking	Package	Packaging
	STP60NF03L	P60NF03L	TO-220	Tube

1/12	Rev 4	August 2006
www.st.com		

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### 1

**Electrical ratings** 

Table 1. Absolute maximum ratings				
Symbol	Parameter	Value	Unit	
V <sub>GS</sub>	Gate-source voltage	30	V	
V <sub>DGR</sub>	Drain-gate Voltage ( $R_{GS} = 20 \text{ k}\Omega$ )	30	V	
V <sub>GS</sub>	Gate- source Voltage	± 20	V	
۱ <sub>D</sub>	Drain current (continuous) at $T_{C} = 25^{\circ}C$	60	Α	
۱ <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> =100°C	42	А	
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	240	А	
P <sub>TOT</sub>	Total dissipation at $T_{C} = 25^{\circ}C$	100	W	
	Derating factor	0.67	W/°C	
E <sub>AS</sub> <sup>(2)</sup>	Single pulse avalanche energy	650	mJ	
Т <sub>Ј</sub>	Operating junction temperature	175	J°	
T <sub>stg</sub>	Storage temperature	-65 to 175	0	

1. Pulse width limited by safe operating area

2. Starting  $T_j = 25^{\circ}C$ ,  $I_D = 30A$ ,  $V_{DD} = 20V$ 

### Table 2.Thermal data

R <sub>thj-case</sub>	Thermal resistance junction-case Max	1.5	°C/W
R <sub>thj-a</sub>	Thermal resistance junction-ambient Max	62.5	°C/W
Rthc-sink	Thermal resistance case-sink typ	0.5	°C/W
т	Maximum lead temperature for soldering purpose	300	°C



# 2 Electrical characteristics

(T<sub>CASE</sub>=25°C unless otherwise specified)

	0					
Symbol	Parameter Test conditions		Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0	30			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = Max rating, V <sub>DS</sub> = Max rating @125°C			1 10	μA μA
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	$V_{GS} = \pm 20V$			± 100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1	1.5	2.5	V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 30A V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 30A		0.008 0.0095	0.010 0.015	Ω Ω

#### Table 3. On/off states

### Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9fs <sup>(1)</sup>	Forward transconductance	$V_{DS} > I_{D(on)} \times R_{DS(on)max,}$ $I_D = 30A$		60		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>DS</sub> =25V, f=1 MHz, V <sub>GS</sub> =0		2550 630 215		pF pF pF
t <sub>d(on)</sub> t <sub>r</sub>	Turn-on Delay Time Rise Time	$\begin{split} V_{DD} &= 15V, \ I_D = 30A, \\ R_G &= 4.7\Omega, \ V_{GS} = 4.5V \\ (see \ Figure \ 12) \end{split}$		40 250		ns ns
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	V <sub>DD</sub> =24V, I <sub>D</sub> = 60A V <sub>GS</sub> =5V		43 12 21	58	nC nC nC

1. Pulsed: pulse duration=300 $\mu$ s, duty cycle 1.5%

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Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I <sub>SD</sub>	Source-drain current				60	А
$I_{SDM}^{(1)}$	Source-drain current (pulsed)				240	А
$V_{SD}^{(2)}$	Forward on voltage	I <sub>SD</sub> =60A, V <sub>GS</sub> =0			1.5	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	I <sub>SD</sub> =60A, di/dt = 100A/μs, V <sub>DD</sub> =15V, Tj=150°C (see Figure 14)		75 100 2.6		ns μC Α

Table 5.Source drain diode

1. Pulse width limited by safe operating area

2. Pulsed: pulse duration=300µs, duty cycle 1.5%



HV02490

5 V<sub>GS</sub>(V)

#### **Electrical characteristics (curves)** 2.1

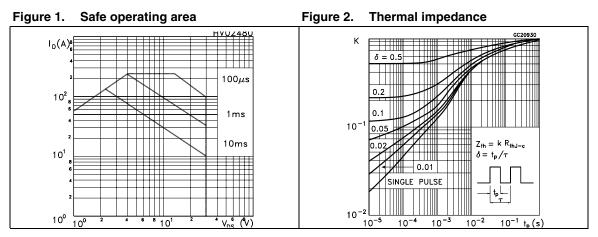
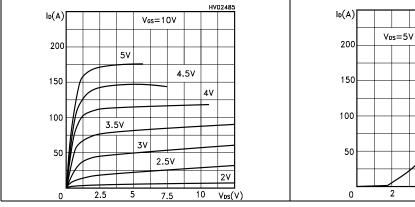
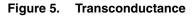
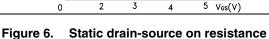


Figure 4.



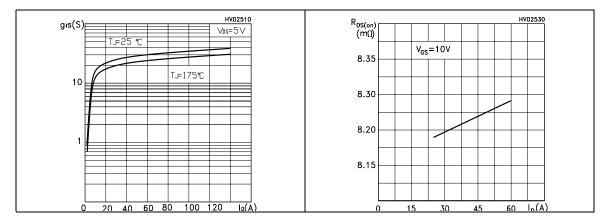






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**Transfer characteristics** 



20

Figure 10. Normalized on resistance vs

temperature

Vcs=10V

l₀=30mA

50

100

Ω

Ros(on)

(norm)

1.2

1.1

0.9

-50

HV02495

Vos(V)

HV02520

(°C)

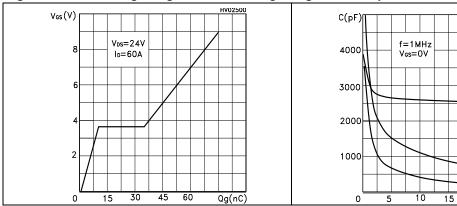


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

Figure 9. Normalized gate threshold voltage vs temperature

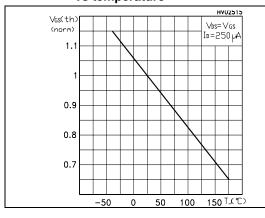
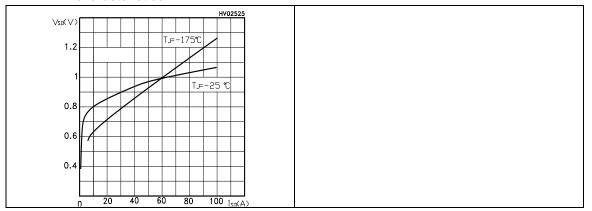


Figure 11. Source-drain diode forward characteristics

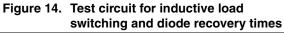


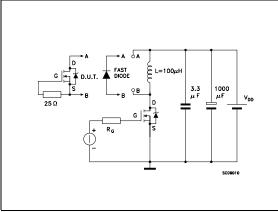


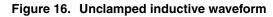
#### 3 **Test circuit**

resistive load 2200 3.3 μF RL μF V<sub>DD</sub> ۷<sub>D</sub> R<sub>G</sub> D.U.T. SC05990

Figure 12. Switching times test circuit for







VDD 1ΚΩ + 100nF

Figure 13. Gate charge test circuit

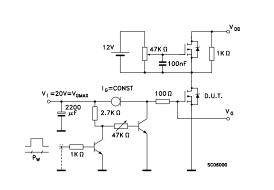
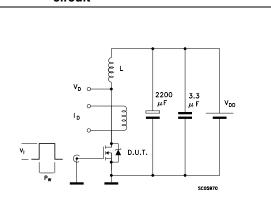
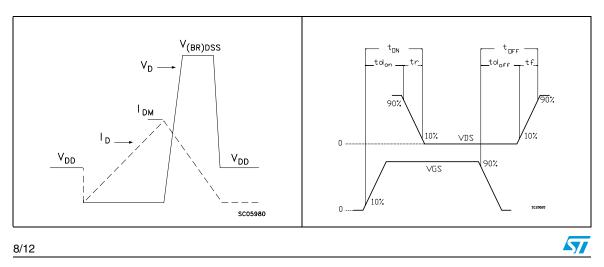


Figure 15. Unclamped Inductive load test circuit







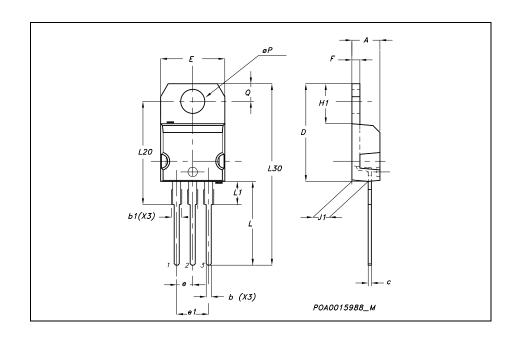
# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com



DIM.		mm.			inch	
	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.15		1.70	0.045		0.066
С	0.49		0.70	0.019		0.027
D	15.25		15.75	0.60		0.620
E	10		10.40	0.393		0.409
е	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.052
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
øP	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116





# 5 Revision history

### Table 6. Revision history

Date	Revision	Changes
09-Sep-2004	3	Complete document
09-Aug-2006	4	New template, no content change



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